Measurement Report for Device, FRONT, D2450, UID 0 -, Channel 50 (2450.0MHz)

Device under Test Properties

Model, Manufactur	er Dir	nensions [mr	n]	IMEI	DUT Type		
Device,	10	00.0 x 20.0 x 2	10.0		Phone		
Exposure Condi	tions						
Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
		D2450	C) 4/	2450.0	0.10	1 77	39.5
Flat,	FRONT,	D2450	CW,	2450.0,	8.18	1.77	39.5

Hardware Setup

Phantom	TSL, Measured Date		Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2178	HSL600-10000 C 2022-Aug-30	Charge: xxxx,	EX3DV4 - SN7733, 2022-08-02	DAE4 Sn1739, 2022-07-29

Scan Setup			Measurement Resul	ts	
	Area Scan	Zoom Scan		Area Scan	Zoom Scan
Grid Extents [mm]	60.0 x 140.0	30.0 x 30.0 x 30.0	Date	2022-08-26, 09:44	2022-08-26, 09:52
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5	psSAR1g [W/kg]	13.9	13.8
Sensor Surface [mm]	3.0	1.4	psSAR10g [W/kg]	6.52	6.45
Graded Grid	Yes	Yes	Power Drift [dB]	0.00	0.01
Grading Ratio	1.5	1.5	Power Scaling	Disabled	Disabled
MAIA	N/A	N/A	Scaling Factor [dB]		
Surface Detection	VMS + 6p	VMS + 6p	TSL Correction	No correction	No correction
Scan Method	Measured	Measured	M2/M1 [%]		80.5
			Dist 3dB Peak [mm]		9.0

Warning(s) / Error(s)

Details Area Scan Warning(s) Error(s)

> Interpolated SAR [W/kg] 28.5 1 0

Measurement Report for Device, FRONT, D5GHz, UID 0 -, Channel 25 (5250.0MHz)

Device under Test Properties

Model, Manufactur	er Din	nensions [mi	m]	IMEI	DUT Type		
Device,	10	00.0 x 20.0 x	10.0		Phone		
Exposure Condi	tions						
Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	FRONT, 5.00	D5GHz	CW, 0	5250.0, 25	5.92	4.68	34.6

Hardware Setup

Phantom	TSL, Measured Date			Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2178	HSL600-10000 2022-Aug-30	Charge:	XXXX,	EX3DV4 - SN7733, 2022-08-02	DAE4 Sn1739, 2022-07-29

Scan Setup			Measurement Resul	ts	
	Area Scan	Zoom Scan		Area Scan	Zoom Scan
Grid Extents [mm]	60.0 x 140.0	22.0 x 22.0 x 22.0	Date	2022-08-26, 11:05	2022-08-26, 11:13
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4	psSAR1g [W/kg]	7.48	8.18
Sensor Surface [mm]	3.0	1.4	psSAR10g [W/kg]	2.29	2.36
Graded Grid	Yes	Yes	Power Drift [dB]	-0.00	0.01
Grading Ratio	1.5	1.4	Power Scaling	Disabled	Disabled
MAIA	N/A	N/A	Scaling Factor [dB]		
Surface Detection	VMS + 6p	VMS + 6p	TSL Correction	No correction	No correction
Scan Method	Measured	Measured	M2/M1 [%]		64.7
			Dist 3dB Peak [mm]		7.2

Warning(s) / Error(s)

Details	Area Scan
Warning(s)	
Error(s)	

Interpolated SAR [W/kg] 10.9

Measurement Report for Device, FRONT, D5GHz, UID 0 -, Channel 60 (5600.0MHz)

Device under Test Properties

Model, Manufacture	er	Dimensions	[mm]	IMEI	DUT Type		
Device,		100.0 x 20.0	0 x 10.0		Phone		
Exposure Condit	ions						
Phantom Section, TSL	Position, Distance [mn	Test Band n]	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	FRONT,	D5GHz	CW,	5600.0,	5.08	5.01	36.1
HSL	0.00		0	60			
Hardware Setup							
Phantom		TSL, Measu	ed Date	Probe, Calibrati	on Date	DAE, Calibration	n Date
ELI V8.0 (20deg prob	e tilt) - 2178	HSL600-100 2022-Aug-30		xxxx, EX3DV4 - SN773	33, 2022-08-02	DAE4 Sn1739, 2	022-07-29

Scan Setup			Measurement Resul	ts	
	Area Scan	Zoom Scan		Area Scan	Zoom Scan
Grid Extents [mm]	60.0 x 140.0	22.0 x 22.0 x 22.0	Date	2022-08-26, 08:25	2022-08-26, 08:33
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4	psSAR1g [W/kg]	8.01	8.69
Sensor Surface [mm]	3.0	1.4	psSAR10g [W/kg]	2.39	2.47
Graded Grid	Yes	Yes	Power Drift [dB]	-0.00	-0.00
Grading Ratio	1.5	1.4	Power Scaling	Disabled	Disabled
MAIA	N/A	N/A	Scaling Factor [dB]		
Surface Detection	VMS + 6p	VMS + 6p	TSL Correction	No correction	No correction
Scan Method	Measured	Measured	M2/M1 [%]		62.0
			Dist 3dB Peak [mm]		7.2

Warning(s) / Error(s)

DetailsArea ScanWarning(s)Error(s)

Interpolated SAR [W/kg] 36.7

Measurement Report for Device, FRONT, D5GHz, UID 0 -, Channel 75 (5750.0MHz)

Device under Test Properties

Model, Manufactur	er Din	nensions [mn	n]	IMEI	DUT Type		
Device,	10	00.0 x 20.0 x 1	10.0		Phone		
Exposure Condi	tions						
Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	FRONT,	D5GHz	CW,	5750.0,	5.15	5.12	36.0
HSL	0.00		0	75			

Phantom

Phantom	TSL, Measured Date		Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2178	HSL600-10000 Charge: 2022-Aug-30	xxxx,	EX3DV4 - SN7733, 2022-08-02	DAE4 Sn1739, 2022-07-29

Scan Setup			Measurement Resu	lts	
	Area Scan	Zoom Scan		Area Scan	Zoom Scan
Grid Extents [mm]	60.0 x 140.0	22.0 x 22.0 x 22.0	Date	2022-08-26, 08:43	2022-08-26, 08:50
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4	psSAR1g [W/kg]	6.89	7.58
Sensor Surface [mm]	3.0	1.4	psSAR10g [W/kg]	2.09	2.16
Graded Grid	Yes	Yes	Power Drift [dB]	-0.00	0.03
Grading Ratio	1.5	1.4	Power Scaling	Disabled	Disabled
MAIA	N/A	N/A	Scaling Factor [dB]		
Surface Detection	VMS + 6p	VMS + 6p	TSL Correction	No correction	No correction
Scan Method	Measured	Measured	M2/M1 [%]		60.7
			Dist 3dB Peak [mm]		7.2

Warning(s) / Error(s)

Details	Area Scan
Warning(s)	
Error(s)	

Interpolated SAR [W/kg] 32.8